

承 認 書 SPECIFICATION FOR APPROVAL

客戶名稱 CUSTOMER	:			
客戶料號 CUSTOMER'S P/N	:			_^
料號 PART NUMBER	: <u>WAN3216F2</u>	45H18		
規格 DESCRIPTION	: Chip Antenna 3	216 L Ant 2.45G	Type H18	*
版本 VERSION	: <u>V1.2</u>			_
日期 ISSUE DATE	2023/06/16		KD,	_
		X		
	客戶承認 CUSTOMER APPROVED			
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4	20			
	工程部 R&D CENTER			
CIT!	承 認 APPROVAL	確 認 CHECKED	製 作 DRAWN	
	Ray	Tennyson	Snow	





萬誠科技股份有限公司

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OneWave Electronic Co., Ltd.

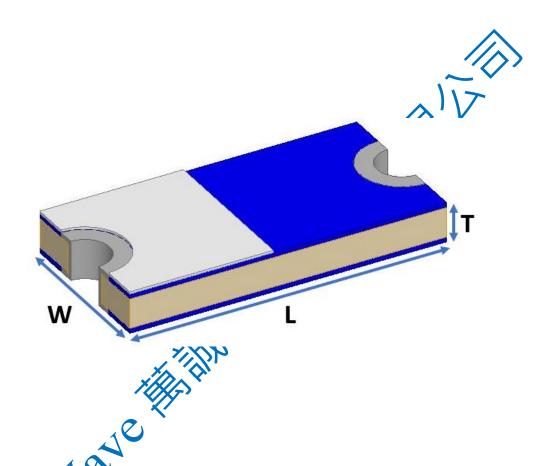
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3216 Chip antenna

For Bluetooth / WLAN Applications



P/N: WAN3216F245H18

	Dimension (mm)		
L	3.23 ± 0.20		
W	1.66 ± 0.20		
Т	0.45 ± 0.20		



Part Number Information

WAN 3216 F 245 H 18
A B C D F

Product Series	Antenna		
Dimension L x W	3.2 x 1.6mm (±0.2mm)		
Material	High K material		
Working Frequency	2.4 ~ 2.5GHz		
Feeding mode	PIFA & Single Feeding		
Antenna type	Type = 18		
	Dimension L x W Material Working Frequency Feeding mode		

1. Electrical Specification

Specification			
Part Number	WAN3216F245H18		
Central Frequency	2450	MHz	
Bandwidth	120 (Min.)	MHz	
Return Loss	-6.5 (Max)	dB	
Peak Gain	1.75	dBi	
Frequency Tolerance	± 15 (備註★)	MHz	
Impedance	50	Ohm	
Operating Temperature	-40~+110	°C	
Maximum Power	4	W	
Resistance to Soldering Heats	10 (@ 260℃)	sec.	
Polarization	Linear		
Azimuth Beamwidth	Omni-directional		
Termination	Cu / Sn (Leadless)		

Remark : Bandwidth & Peak Gain was measured under evaluation board of next page

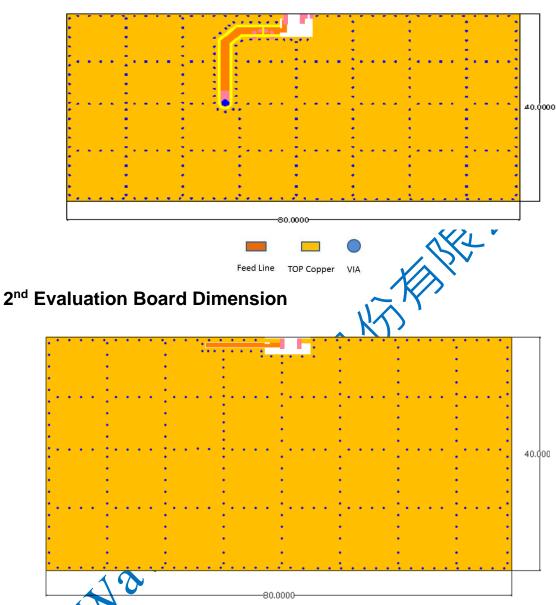
★ 頻率公差可能因以下問題造成公差變大:

- 1. PCB RF Trace 阻抗公差大
- 2. 天線周邊 Layout 設計不佳
- ★ 此天線與 WAN3216F245H08 為相同產品,但此天線的公差較小,為高精度的料



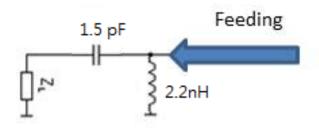
2. Recommended PCB Pattern

Recommended PCB Pattern 若未參照我司規格書上Layout建議做設計, Evaluation Board Dimension 進而造成後續生產上的天線特性與品質差異問題,



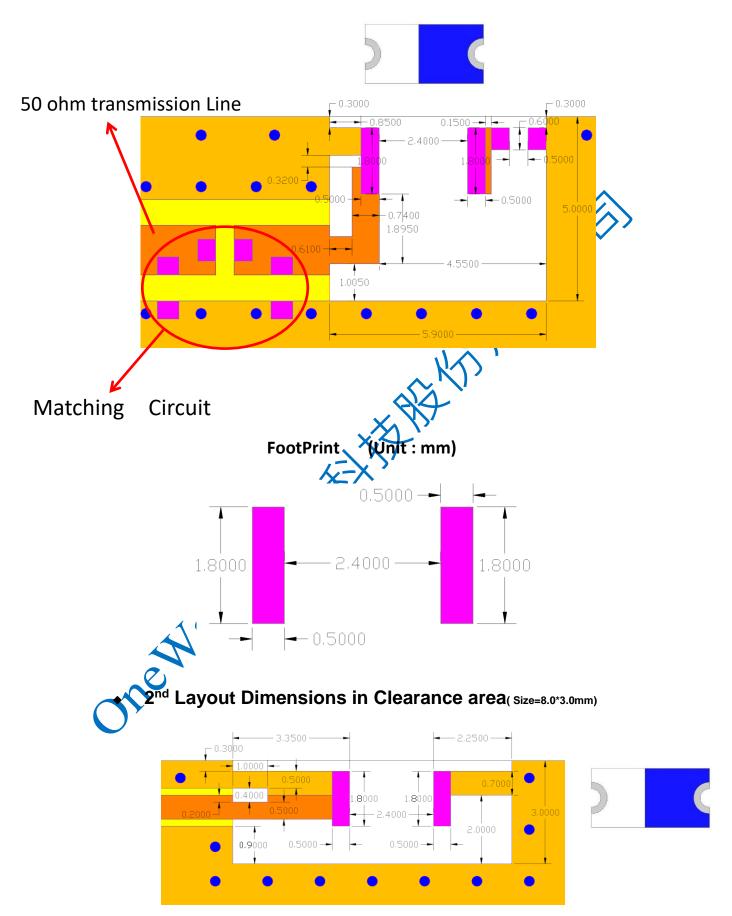
Suggested Matching Circuit

牛建議使用精準度高的電感±0.1~0.3nH、電容±0.1pF



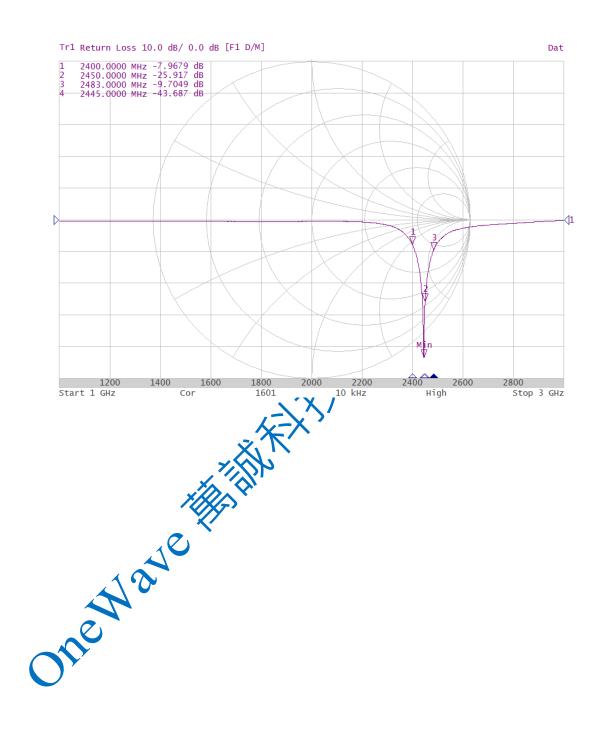


Layout Dimensions in Clearance area(Size=5.9*5.0mm)



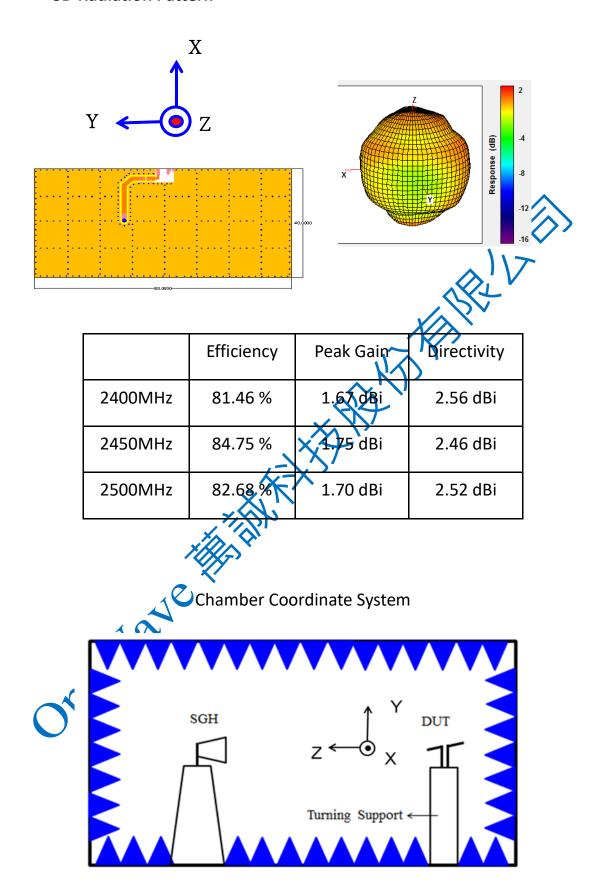


3. Measurement Results Return Loss





3D Radiation Pattern





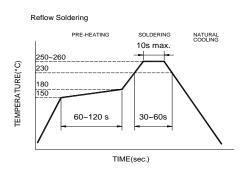
4.Reliability and Test Condictions

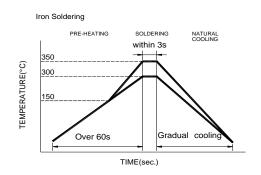
ITEM	REQUIREMENTS	TEST CONDITION
Solderability	Wetting shall exceed 90% coverage No visible mechanical damage	Pre-heating temperature:150°C /60sec.
	2. NO VISIBLE MECHANICAL GAMAGE	Solder temperature:230±5°C
	TEMP (°C)	Duration:4±1sec. Solder:Sn-Ag3.0-Cu0.5
	230℃ 4±1 sec.	Flux for lead free: rosin
	2500	
	150℃	
	60sec	
Solder heat	No visible mechanical damage	Due heating to see a set use 450°C /COcce
Resistance	Central Freq. change :within ± 6%	Pre-heating temperature:150°C/60sec. Solder temperature:260±5°C
	TEMP (°C)	Duration:10±0.5sec.
		Solder:Sn-Ag3.0-Cu0.5
	260°C 10±0.5 sec.	Flux for lead free: rosin
	150°C	
	130 C	N/L
	/ 60sec \	150
		<i>X</i> / <i>X</i> \
Component Adhesion	No visible mechanical damage	The device should be reflow soldered(280±5°C for 10sec.) to a tinned
(Push test)		copper substrate A dynometer force
	_	gauge should be applied the side of the
		component. The device must with-ST-F
	V X	0.5 Kg without failure of the termination attached to component.
Component	No visible mechanical damage	Insert 10cm wire into the remaining open
Adhesion	XT	eye bend ,the ends of even wire lengths
(Pull test)	λ-x >	upward and wind together.
,	27	Terminal shall not be remarkably
		damaged.
Thermal shock	No visible mechanical damage	+110°C =>30±3min -40°C =>30±3min
	2. Central Freq. change :within ±6%	Test cycle:10 cycles
	Phase Temperature(°C) Time(min)	The chip shall be stabilized at normal
	1 +110±5°C 30±3	condition for 2~3 hours before
	2 Room Within	measuring.
	Temperature 3sec	
	3 -40±2°C 30±3	
	Room Within	
	Temperature 3sec	
Resistance to	1. No visible mechanical damage	Temperature: +110±5°C
High	2. Central Freq. change :within ±6%	Duration: 1000±12hrs
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal
		condition for 2~3 hours before measuring.
Resistance to	No visible mechanical damage	Temperature:-40±5°C
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal
·	3. NO disconnection of Short diffult.	condition for 2~3 hours before
		measuring.
Humidity		L Lomporaturo: 40+2°C
Humidity	No visible mechanical damage	Temperature: 40±2°C
Humidity	2. Central Freq. change :within ±6%	Humidity: 90% to 95% RH
Humidity		Humidity: 90% to 95% RH Duration: 1000±12hrs
Humidity	2. Central Freq. change :within ±6%	Humidity: 90% to 95% RH



5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.





Recommended temperature profiles for re-flow soldering in Figure 1.

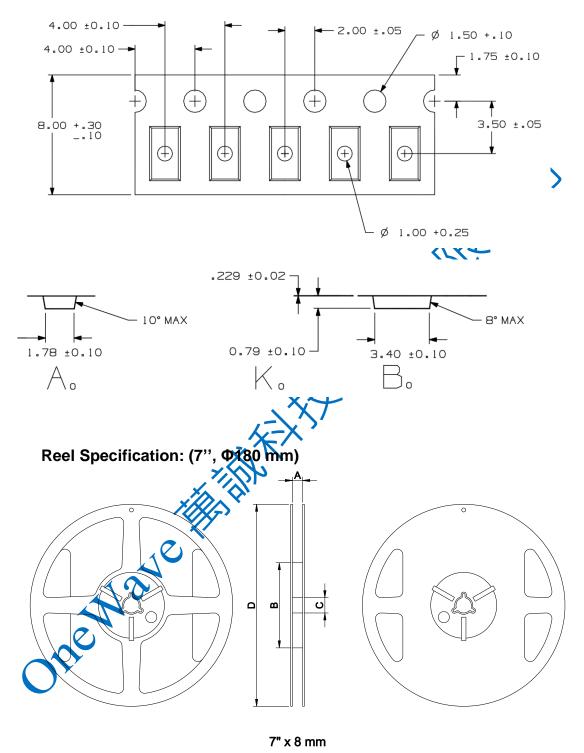
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

- Preheat circuit and products to 150°C
- · Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280° (tip temperature (max))
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.



6.Packaging Information

Tape Specification:



Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000



7.Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

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- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.